## Application/Control No. O9/869,747 Applicant(s)/Patent Under Reexamination TAI, TOSHIHIRO Examiner Katarzyna Wyrozebski Lee Art Unit Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,075,114	06-2000	Umetsu et al.	528/272
	В	US-			
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	Κ	US-			
	L	US-			
	М	US-			

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## **NON-PATENT DOCUMENTS**

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